

## PSMN5R0-80BS

# N-channel 80 V, 5.1 mΩ standard level MOSFET in D2PAK Rev. 1 — 20 March 2012 Product data s

**Product data sheet** 

## **Product profile**

## 1.1 General description

Standard level N-channel MOSFET in SOT404 package qualified to 175 °C. This product is designed and qualified for use in a wide range of industrial, communications and domestic equipment.

#### 1.2 Features and benefits

- High efficiency due to low switching and conduction losses
- Suitable for standard level gate drive sources

## 1.3 Applications

- DC-to-DC converters
- Load switching

- Motor control
- Server power supplies

#### 1.4 Quick reference data

Table 1. Quick reference data

| Symbol                 | Parameter                                    | Conditions   |     | Min | Тур  | Max | Unit |
|------------------------|--|--|-----|-----|------|-----|------|
| $V_{DS}$               | drain-source voltage                         | T <sub>j</sub> ≥ 25 °C; T <sub>j</sub> ≤ 175 °C  |     | -   | -    | 80  | V    |
| I <sub>D</sub>         | drain current                                | $T_{mb}$ = 25 °C; $V_{GS}$ = 10 V;<br>see <u>Figure 1</u>  | [1] | -   | -    | 100 | Α    |
| P <sub>tot</sub>       | total power dissipation                      | T <sub>mb</sub> = 25 °C; see <u>Figure 2</u>   |     | -   | -    | 270 | W    |
| T <sub>j</sub>         | junction temperature                         |  |     | -55 | -    | 175 | °C   |
| Static characteristics |  |  |     |     |      |     |      |
| R <sub>DSon</sub>      | drain-source on-state resistance             | $V_{GS} = 10 \text{ V}; I_D = 25 \text{ A}; T_j = 100 ^{\circ}\text{C};$<br>see Figure 13; see Figure 12 |     | -   | 7.19 | 8.5 | mΩ   |
|                        |  | $V_{GS} = 10 \text{ V}; I_D = 25 \text{ A}; T_j = 25 \text{ °C};$<br>see <u>Figure 12</u>                |     | -   | 4.36 | 5.1 | mΩ   |
| Dynamic ch             | aracteristics                                |  |     |     |      |     |      |
| $Q_{GD}$               | gate-drain charge                            | $V_{GS} = 10 \text{ V}; I_D = 25 \text{ A}; V_{DS} = 40 \text{ V};$                                      |     | -   | 21   | -   | nC   |
| Q <sub>G(tot)</sub>    | total gate charge                            | see <u>Figure 14</u> ; see <u>Figure 15</u>  |     | -   | 101  | -   | nC   |
| Avalanche i            | ruggedness                                   |  |     |     |      |     |      |
| E <sub>DS(AL)S</sub>   | non-repetitive drain-source avalanche energy | $V_{GS}$ = 10 V; $T_{j(init)}$ = 25 °C; $I_D$ = 100 A; $V_{sup}$ ≤ 80 V; $R_{GS}$ = 50 Ω; unclamped      |     | -   | -    | 396 | mJ   |

<sup>[1]</sup> Continuous current is limited by package



## 2. Pinning information

Table 2. Pinning information

| I doic L. |        | , illiorination                   |                    |                |
|-----------|--------|-----------------------------------|--------------------|----------------|
| Pin       | Symbol | Description                       | Simplified outline | Graphic symbol |
| 1         | G      | gate                              |                    | _              |
| 2         | D      | drain[1]                          | mb                 | D              |
| 3         | S      | source                            |                    |                |
| mb        | D      | mounting base; connected to drain |                    | mbb076 S       |
|           |        |                                   | SOT404 (D2PAK)     |                |
|           |        |                                   |                    |                |

<sup>[1]</sup> It is not possible to make connection to pin 2

## 3. Ordering information

Table 3. Ordering information

| Type number  | Package |  |         |
|--------------|---------|--|---------|
|              | Name    | Description  | Version |
| PSMN5R0-80BS | D2PAK   | plastic single-ended surface-mounted package (D2PAK); 3 leads (one lead cropped) | SOT404  |

## 4. Marking

Table 4. Marking codes

| Type number  | Marking code |
|--------------|--------------|
| PSMN5R0-80BS | PSMN5R0-80BS |

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## 5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol               | Parameter                                    | Conditions  |            | Min | Max | Unit |
|----------------------|--|---|------------|-----|-----|------|
| $V_{DS}$             | drain-source voltage                         | T <sub>j</sub> ≥ 25 °C; T <sub>j</sub> ≤ 175 °C   |            | -   | 80  | V    |
| $V_{DGR}$            | drain-gate voltage                           | $T_j \ge 25 \text{ °C}; T_j \le 175 \text{ °C}; R_{GS} = 20 \text{ k}\Omega$                                |            | -   | 80  | V    |
| $V_{GS}$             | gate-source voltage                          |   |            | -20 | 20  | V    |
| I <sub>D</sub>       | drain current                                | V <sub>GS</sub> = 10 V; T <sub>mb</sub> = 100 °C; see <u>Figure 1</u>                                       | <u>[1]</u> | -   | 100 | Α    |
|                      |  | V <sub>GS</sub> = 10 V; T <sub>mb</sub> = 25 °C; see <u>Figure 1</u>  | <u>[1]</u> | -   | 100 | Α    |
| I <sub>DM</sub>      | peak drain current                           | pulsed; $t_p \le 10 \mu s$ ; $T_{mb} = 25 \text{ °C}$ ; see Figure 3  |            | -   | 598 | Α    |
| P <sub>tot</sub>     | total power dissipation                      | T <sub>mb</sub> = 25 °C; see <u>Figure 2</u>  |            | -   | 270 | W    |
| T <sub>stg</sub>     | storage temperature                          |   |            | -55 | 175 | °C   |
| Tj                   | junction temperature                         |   |            | -55 | 175 | °C   |
| T <sub>sld(M)</sub>  | peak soldering temperature                   |   |            | -   | 260 | °C   |
| Source-dra           | in diode                                     |   |            |     |     |      |
| Is                   | source current                               | T <sub>mb</sub> = 25 °C   | [1]        | -   | 100 | Α    |
| I <sub>SM</sub>      | peak source current                          | pulsed; $t_p \le 10 \mu s$ ; $T_{mb} = 25  ^{\circ}C$   |            | -   | 598 | Α    |
| Avalanche            | ruggedness                                   |   |            |     |     |      |
| E <sub>DS(AL)S</sub> | non-repetitive drain-source avalanche energy | $V_{GS}$ = 10 V; $T_{j(init)}$ = 25 °C; $I_D$ = 100 A; $V_{sup}$ ≤ 80 V; $R_{GS}$ = 50 $\Omega$ ; unclamped |            | -   | 396 | mJ   |

#### [1] Continuous current is limited by package

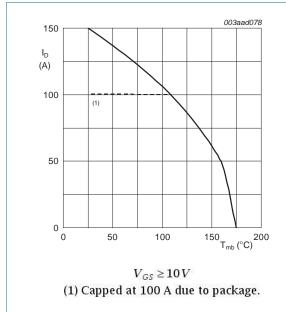
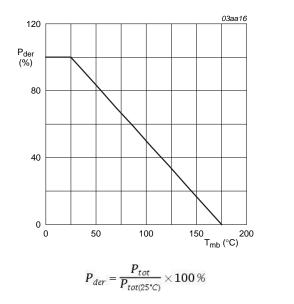
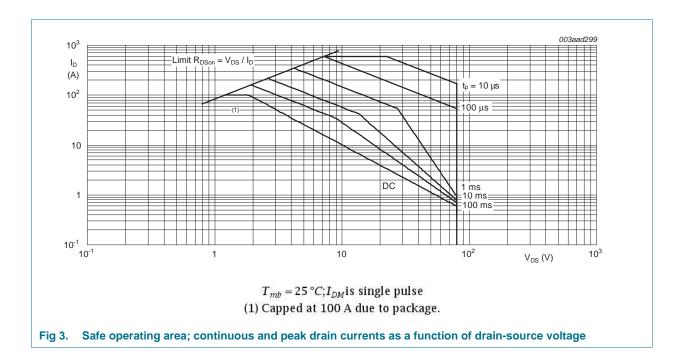


Fig 1. Continuous drain current as a function of mounting base temperature



ig 2. Normalized total power dissipation as a function of mounting base temperature

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## 6. Thermal characteristics

Table 6. Thermal characteristics

| Symbol         | Parameter   | Conditions  | Min | Тур | Max  | Unit |
|----------------|---|---|-----|-----|------|------|
| $R_{th(j-mb)}$ | thermal resistance from junction to mounting base | see Figure 4  | -   | 0.3 | 0.56 | K/W  |
| $R_{th(j-a)}$  | thermal resistance from junction to ambient       | Minimum footprint; mounted on a printed circuit board | -   | 50  | -    | K/W  |

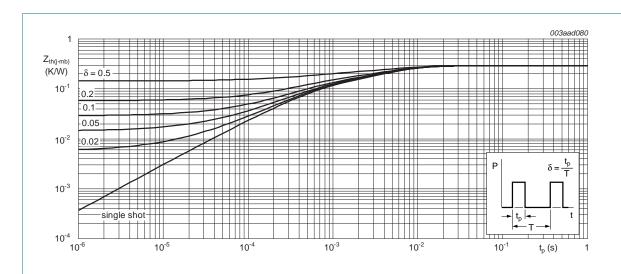


Fig 4. Transient thermal impedance from junction to mounting base as a function of pulse duration; typical values

## 7. Characteristics

Table 7. Characteristics

Tested to JEDEC standards where applicable.

| Symbol                 | Parameter                         | Conditions   | Min | Тур   | Max  | Unit |
|------------------------|-----------------------------------|--|-----|-------|------|------|
| Static char            | acteristics                       |  |     |       |      |      |
| V <sub>(BR)DSS</sub>   | drain-source breakdown voltage    | $I_D = 250 \mu A; V_{GS} = 0 V; T_j = -55 °C$  | 73  | -     | -    | V    |
|                        |                                   | $I_D = 250 \ \mu A; \ V_{GS} = 0 \ V; \ T_j = 25 \ ^{\circ}C$  | 80  | -     | -    | V    |
| V <sub>GS(th)</sub>    | gate-source threshold voltage     | $I_D = 1$ mA; $V_{DS} = V_{GS}$ ; $T_j = 175$ °C; see Figure 10  | 1   | -     | -    | V    |
|                        |                                   | $I_D = 1 \text{ mA}$ ; $V_{DS} = V_{GS}$ ; $T_j = -55 \text{ °C}$ ; see Figure 10                        | -   | -     | 4.6  | V    |
|                        |                                   | $I_D = 1$ mA; $V_{DS} = V_{GS}$ ; $T_j = 25$ °C;<br>see <u>Figure 11</u> ; see <u>Figure 10</u>          | 2   | 3     | 4    | V    |
| I <sub>DSS</sub>       | drain leakage current             | $V_{DS} = 80 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$                                       | -   | 0.02  | 8    | μΑ   |
|                        |                                   | $V_{DS} = 80 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 125 \text{ °C}$                                      | -   | -     | 150  | μΑ   |
| I <sub>GSS</sub>       | gate leakage current              | $V_{GS} = -20 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$                                      | -   | 10    | 100  | nA   |
|                        |                                   | $V_{GS} = 20 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$                                       | -   | 10    | 100  | nA   |
| $R_{DSon}$             | drain-source on-state resistance  | $V_{GS} = 10 \text{ V}; I_D = 25 \text{ A}; T_j = 175 ^{\circ}\text{C};$<br>see Figure 12; see Figure 13 | -   | 10.46 | 12.3 | Ω    |
|                        |                                   | $V_{GS} = 10 \text{ V}; I_D = 25 \text{ A}; T_j = 100 ^{\circ}\text{C};$<br>see Figure 13; see Figure 12 | -   | 7.19  | 8.5  | mΩ   |
|                        |                                   | $V_{GS} = 10 \text{ V}; I_D = 25 \text{ A}; T_j = 25 \text{ °C};$<br>see Figure 12                       | -   | 4.36  | 5.1  | mΩ   |
| R <sub>G</sub>         | internal gate resistance (AC)     | f = 1 MHz  | -   | 0.95  | -    | Ω    |
| Dynamic cl             | haracteristics                    |  |     |       |      |      |
| $Q_{G(tot)}$           | total gate charge                 | $I_D = 0 A; V_{DS} = 0 V; V_{GS} = 10 V$   | -   | 87    | -    | nC   |
|                        |                                   | $I_D = 25 \text{ A}$ ; $V_{DS} = 40 \text{ V}$ ; $V_{GS} = 10 \text{ V}$ ;                               | -   | 101   | -    | nC   |
| $Q_{GS}$               | gate-source charge                | see <u>Figure 14</u> ; see <u>Figure 15</u>  | -   | 26    | -    | nC   |
| Q <sub>GS(th)</sub>    | pre-threshold gate-source charge  |  | -   | 18    | -    | nC   |
| Q <sub>GS(th-pl)</sub> | post-threshold gate-source charge |  | -   | 8     | -    | nC   |
| $Q_{GD}$               | gate-drain charge                 |  | -   | 21    | -    | nC   |
| V <sub>GS(pI)</sub>    | gate-source plateau voltage       | $I_D = 25 \text{ A}$ ; $V_{DS} = 40 \text{ V}$ ; see Figure 14; see Figure 15                            | -   | 4.2   | -    | V    |
| C <sub>iss</sub>       | input capacitance                 | $V_{DS} = 40 \text{ V}; V_{GS} = 0 \text{ V}; f = 1 \text{ MHz};$  | -   | 6793  | -    | pF   |
| C <sub>oss</sub>       | output capacitance                | T <sub>j</sub> = 25 °C; see <u>Figure 16</u>   | -   | 913   | -    | pF   |
| C <sub>rss</sub>       | reverse transfer capacitance      |  | -   | 350   | -    | pF   |
| t <sub>d(on)</sub>     | turn-on delay time                | $V_{DS} = 40 \text{ V}; R_L = 0.5 \Omega; V_{GS} = 10 \text{ V};$  | -   | 33    | -    | ns   |
| t <sub>r</sub>         | rise time                         | $R_{G(ext)} = 4.7 \Omega$  | -   | 21    | -    | ns   |
| $t_{\text{d(off)}}$    | turn-off delay time               |  | -   | 73    | -    | ns   |
| t <sub>f</sub>         | fall time                         |  | -   | 14    | -    | ns   |

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Table 7. Characteristics ... continued Tested to JEDEC standards where applicable.

| Symbol          | Parameter             | Conditions  | Min | Тур | Max | Unit |
|-----------------|-----------------------|---|-----|-----|-----|------|
| Source-drai     | n diode               |   |     |     |     |      |
| V <sub>SD</sub> | source-drain voltage  | $I_S = 25 \text{ A}$ ; $V_{GS} = 0 \text{ V}$ ; $T_j = 25 \text{ °C}$ ; see Figure 17 | -   | 0.8 | 1.2 | V    |
| t <sub>rr</sub> | reverse recovery time | $I_S = 25 \text{ A}$ ; $dI_S/dt = 100 \text{ A/}\mu\text{s}$ ;                        | -   | 56  | -   | ns   |
| Q <sub>r</sub>  | recovered charge      | $V_{GS} = 0 \text{ V}; V_{DS} = 40 \text{ V}$   | -   | 116 | -   | nC   |

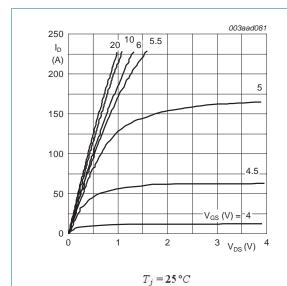
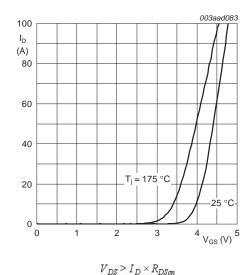
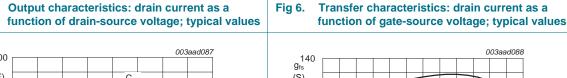


Fig 5. Output characteristics: drain current as a





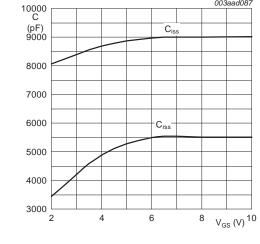
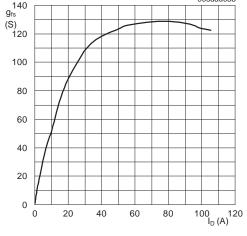


Fig 7. Input and reverse transfer capacitances as a function of gate-source voltage; typical values

 $V_{DS} = 0V; f = 1MHz$ 



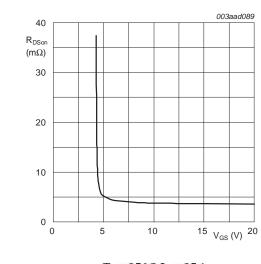
 $T_j = 25 \,{}^{\circ}C; V_{DS} = 15 V$ 

Fig 8. Forward transconductance as a function of drain current; typical values

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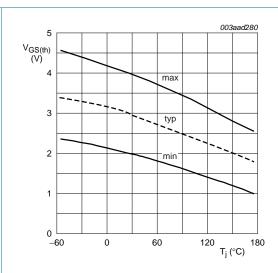
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 $T_j = 25\,^{\circ}C; I_D = 25A$ 

Fig 9. Drain-source on-state resistance as a function of gate-source voltage; typical values



$$I_D = 1 \text{ mA}; \ V_{DS} = V_{GS}$$

Fig 10. Gate-source threshold voltage as a function of junction temperature

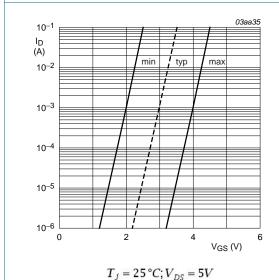


Fig 11. Sub-threshold drain current as a function of gate-source voltage

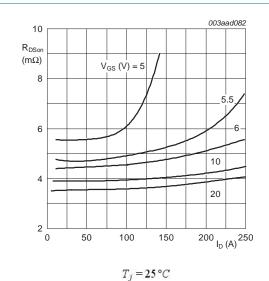
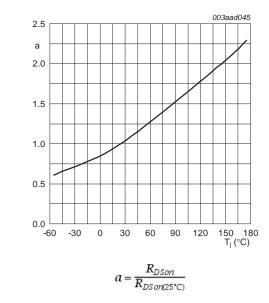


Fig 12. Drain-source on-state resistance as a function of drain current; typical values



V<sub>DS</sub>

V<sub>GS(pl)</sub>

V<sub>GS(th)</sub>

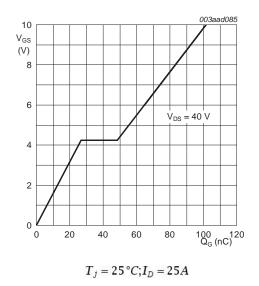
V<sub>GS</sub>

Q<sub>GS1</sub>
Q<sub>GS2</sub>
Q<sub>G(tot)</sub>

003aaa508

Fig 13. Normalized drain-source on-state resistance factor as a function of junction temperature

Fig 14. Gate charge waveform definitions



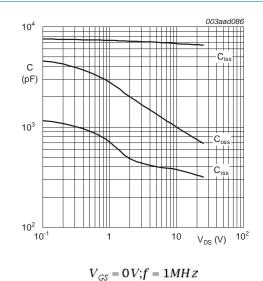
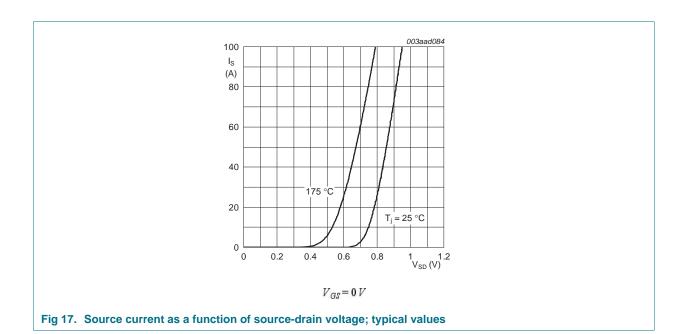


Fig 15. Gate-source voltage as a function of gate charge; typical values





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## 8. Package outline

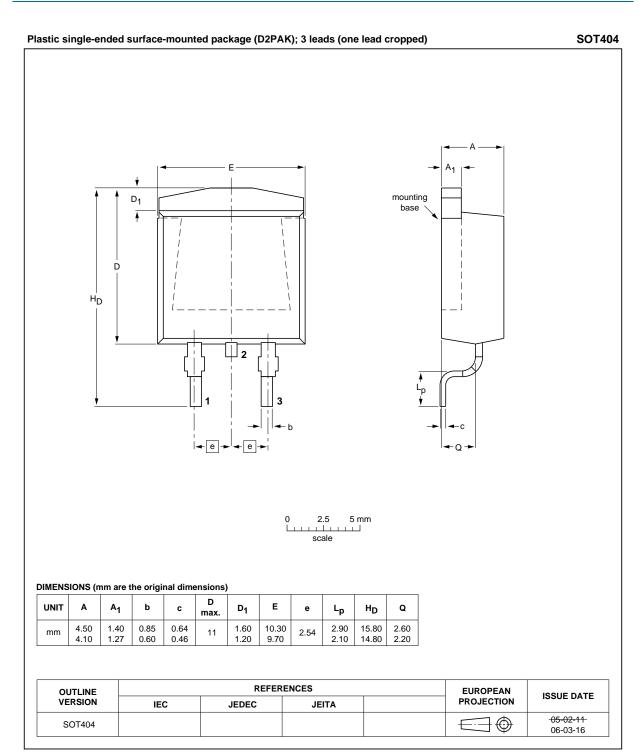


Fig 18. Package outline SOT404 (D2PAK)

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Product data sheet

## 9. Revision history

## Table 8. Revision history

| Document ID      | Release date | Data sheet status  | Change notice | Supersedes |
|------------------|--------------|--------------------|---------------|------------|
| PSMN5R0-80BS v.1 | 20120320     | Product data sheet | -             | -          |

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#### 10.1 Data sheet status

| Document status[1] [2]         | Product status[3] | Definition  |
|--------------------------------|-------------------|---|
| Objective [short] data sheet   | Development       | This document contains data from the objective specification for product development. |
| Preliminary [short] data sheet | Qualification     | This document contains data from the preliminary specification.                       |
| Product [short] data sheet     | Production        | This document contains the product specification.                                     |

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## 11. Contact information

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